

<b>Notice of References Cited</b>		Application/Control No. 10/585,104	Applicant(s)/Patent Under Reexamination HIRAKAWA ET AL.	
		Examiner Igor Kershteyn	Art Unit 3745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,197,850	03-1993	Shinobu et al.	415/53.1
*	B	US-6,050,773	04-2000	Bushnell, Peter R.	415/53.1
*	C	US-6,692,223	02-2004	Ikeda et al.	415/53.1
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 05172085 A	07-1993	Japan	YOSHIHASHI, ATSUSHI	
	O					
	P					
	Q					
	R					
	S					
	I					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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